Single 2-Input AND Gate

The NL17SG08 MiniGate[™] is an advanced high-speed CMOS 2-input AND gate in ultra-small footprint.

The NL17SG08 input structures provides protection when voltages up to 4.6 V are applied.

Features

- Wide Operating V_{CC} Range: 0.9 V to 3.6 V
- High Speed: t_{PD} = 2.5 ns (Typ) at V_{CC} = 3.0 V, C_L = 15 pF
- Low Power Dissipation: $I_{CC} = 0.5 \ \mu A$ (Max) at $T_A = 25^{\circ}C$
- 4.6 V Overvoltage Tolerant (OVT) Input Pins
- Ultra-Small Packages
- These are Pb-Free and Halide-Free Devices

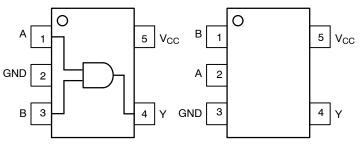


Figure 1. SOT-953 (Top Thru View)



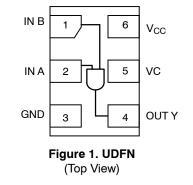




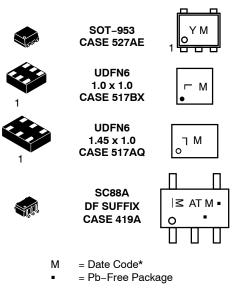
Figure 2. Logic Symbol



ON Semiconductor®

http://onsemi.com

MARKING DIAGRAMS



(Note: Microdot may be in either location)

*Date Code orientation and/or position may vary depending upon manufacturing location.

PIN ASSIGNMENT						
1	IN A					
2	GND					
3	IN B					
4	OUT Y					
5	V _{CC}					

FUNCTION TABLE

Inp	uts	Output
Α	В	Y
L	L	L
L	н	L
н	L	L
Н	Н	Н

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

MAXIMUM RATINGS

Symbol	Parameter		Value	Unit
V _{CC}	DC Supply Voltage	–0.5 to +5.5	V	
V _{IN}	DC Input Voltage		-0.5 to +4.6	V
V _{OUT}	DC Output Voltage Pov	Output at High or Low State wer-Down Mode ($V_{CC} = 0 V$)	-0.5 to V _{CC} +0.5 -0.5 to +4.6	V
Ι _{ΙΚ}	DC Input Diode Current	V _{IN} < GND	-20	mA
Ι _{ΟΚ}	DC Output Diode Current	-20	mA	
I _{OUT}	DC Output Source/Sink Current		±20	mA
I _{CC}	DC Supply Current per Supply Pin		±20	mA
I _{GND}	DC Ground Current per Ground Pin		±20	mA
T _{STG}	Storage Temperature Range		-65 to +150	°C
ΤL	Lead Temperature, 1 mm from Case for 10 Seconds		260	°C
TJ	Junction Temperature Under Bias		+150	°C
MSL	Moisture Sensitivity		Level 1	
F _R	Flammability Rating	Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in	
V_{ESD}	ESD Withstand Voltage	Human Body Model (Note 2) Machine Model (Note 3)	>2000 >100	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.
Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2-ounce copper trace with no air flow.
Tested to EIA/JESD22-A114-A.

3. Tested to EIA/JESD22-A115-A.

RECOMMENDED OPERATING CONDITIONS

Symbol	Characteristics	Min	Max	Unit
V _{CC}	Positive DC Supply Voltage	0.9	3.6	V
V _{IN}	Digital Input Voltage	0.0	3.6	V
V _{OUT}	Output Voltage Output at High or Low State Power-Down Mode (V _{CC} = 0 V)	0.0 0.0	V _{CC} 3.6	V
T _A	Operating Temperature Range	-55	+125	°C
$\Delta t / \Delta V$	Input Transition Rise or Fail Rate $$V_{CC}$$ = 3.3 V \pm 0.3 V	0	10	ns/V

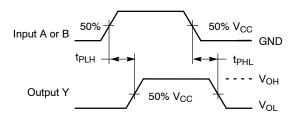
DC ELECTRICAL CHARACTERISTICS

					T _A =	25°C		∖ = o +125°C	
Symbol Parameter		C	Conditions V _{CC} (V)		Min	Max	Min	Max	Unit
VIH	High-Level Input			0.9	V _{CC}		V _{CC}		V
	Voltage			1.1 to 1.3	0.7xV _{CC}		0.7xV _{CC}		
				1.4 to 1.6	$0.65 \mathrm{xV}_{\mathrm{CC}}$		$0.65 \mathrm{xV}_{\mathrm{CC}}$		
				1.65 to 1.95	$0.65 \mathrm{xV}_{\mathrm{CC}}$		$0.65 \mathrm{xV}_{\mathrm{CC}}$		
				2.3 to 2.7	1.7		1.7		
				3.0 to 3.6	2.0		2.0		
VIL	Low-Level Input			0.9		GND		GND	V
	Voltage			1.1 to 1.3		0.3xV _{CC}		0.3xV _{CC}	
				1.4 to 1.6		$0.35 \mathrm{xV}_{\mathrm{CC}}$		0.35xV _{CC}	
				1.65 to 1.95		$0.35 \mathrm{xV}_{\mathrm{CC}}$		0.35xV _{CC}	
				2.3 to 2.7		0.7		0.7	
				3.0 to 3.6		0.8		0.8	
V _{OH}		V _{IN} =	I _{OH} = –20 μA	0.9	0.75		0.75		V
	Output Voltage	V _{IH} or V _{IL}	I _{OH} = -0.3 mA	1.1 to 1.3	$0.75 \mathrm{xV}_{\mathrm{CC}}$		$0.75 \mathrm{xV}_{\mathrm{CC}}$		
			I _{OH} = -1.7 mA	1.4 to 1.6	$0.75 \mathrm{xV}_{\mathrm{CC}}$		$0.75 \mathrm{xV}_{\mathrm{CC}}$		
			I _{OH} = -3.0 mA	1.65 to 1.95	Vcc-0.45		Vcc-0.45		
			I _{OH} = -4.0 mA	2.3 to 2.7	2.0		2.0		
			I _{OH} = -8.0 mA	3.0 to 3.6	2.48		2.48		
V _{OL}	Low-Level	V _{IN} =	I _{OL} = 20 μA	0.9		0.1		0.1	V
	Output Voltage	V _{IH} or V _{IL}	I _{OL} = 1.1 mA	1.1 to 1.3		$0.25 \text{xV}_{\text{CC}}$		0.25xV _{CC}	
			I _{OL} = 1.7 mA	1.4 to 1.6		$0.25 \text{xV}_{\text{CC}}$		0.25xV _{CC}	
			I _{OL} = 3.0 mA	1.65 to 1.95		0.45		0.45	
			I _{OL} = 4.0 mA	2.3 to 2.7		0.4		0.4	
			I _{OL} = 8.0 mA	3.0 to 3.6		0.4		0.4	
I _{IN}	Input Leakage Current	0 ≤	$V_{IN} \leq 3.6 V$	0 to 3.6		±0.1		±1.0	μA
I _{CC}	Quiescent Supply Current	V _{IN} =	V _{CC} or GND	3.6		0.5		10.0	μA

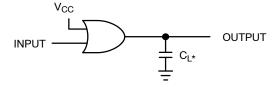
Symbol Parameter		arameter Test Condition V _C		T _A = 25° ($T_A = 25^{\circ} C$ $T_A = -55^{\circ}C \text{ to } +125^{\circ}$									
-				Min	Тур	Max	Min	Max	Unit						
t _{PLH} ,	Propagation Delay,	$C_L = 10 \text{ pF},$	0.9	-	10.0	12.4	-	14.8	ns						
t _{PHL}	A or B to Y	$R_L = 1 M\Omega$	1.1 to 1.3	-	8.0	10.7	-	13.6							
			1.4 to 1.6	-	5.9	9.6	-	11.3							
			1.65 to 1.95	-	4.5	7.0	-	7.5							
			2.3 to 2.7	-	2.9	4.4	-	4.9							
			3.0 to 3.6	-	2.2	3.5	-	4.1							
		C _L = 15 pF, R _L = 1 MΩ	0.9	-	11.7	13.5	-	15.0	ns						
			$R_L = 1 M\Omega^2$	1.1 to 1.3	-	8.8	10.2	-	13.7	1					
			1.4 to 1.6	-	6.5	9.5	-	12.6							
				1.65 to 1.95	-	5.0	7.7	-	8.0						
									2.3 to 2.7	-	3.2	4.9	-	5.6	
				3.0 to 3.6	-	2.5	3.8	-	4.4						
		$C_L = 30 \text{ pF},$	0.9	-	13.0	16.0	-	19.0	ns						
		$R_{L} = 1 M\Omega$	1.1 to 1.3	-	10.0	12.4	-	17.2							
			1.4 to 1.6	-	8.9	11.8	-	14.9							
			1.65 to 1.95	-	6.9	10.3	-	10.8							
			2.3 to 2.7	-	4.4	6.4	-	6.8	1						
			3.0 to 3.6	-	3.5	4.9	-	5.4	1						
C _{IN}	Input Capacitance		0 to 3.6		3	-	-	-	pF						
C _{PD}	Power Dissipation Capacitance (Note 4)	f = 10 MHz	0.9 to 3.6	-	4	-	-	-	pF						

AC ELECTRICAL CHARACTERISTICS Input $t_r = t_f = 3.0 \text{ ns}$

4. C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: $I_{CC(OPR)} = C_{PD} \bullet V_{CC} \bullet f_{in} + I_{CC}$. C_{PD} is used to determine the no–load dynamic power consumption; $P_D = C_{PD} \bullet V_{CC}^2 \bullet f_{in} + I_{CC} \bullet V_{CC}$.







*Includes all probe and jig capacitance. A 1-MHz square input wave is recommended for propagation delay tests.

Figure 3. Test Circuit

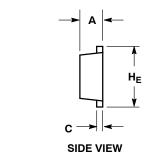
ORDERING INFORMATION

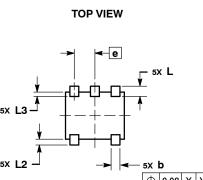
Device	Package	Shipping [†]
NL17SG08P5T5G	SOT-953 (Pb-Free)	8000 / Tape & Reel
NL17SG08DFT2G*	SC88A (Pb-Free)	3000 / Tape & Reel
NL17SG08AMUTCG*	UDFN6 1.45x1 mm (Pb-Free)	3000 / Tape & Reel
NL17SG08CMUTCG*	UDFN6 1x1 mm (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D. *In Development

PACKAGE DIMENSIONS

SOT-953 CASE 527AE ISSUE E





D

2 Ό1

4

3

5

X

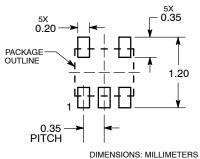
Y

Ε

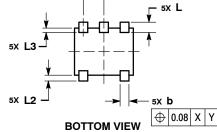
NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.34	0.37	0.40			
b	0.10	0.15 0.20				
С	0.07	0.12	0.17			
D	0.95	1.00	1.05			
E	0.75	0.80	0.85			
е		0.35 BS	С			
ΗE	0.95	1.00	1.05			
L	0.175 REF					
L2	0.05	0.10	0.15			
L3			0.15			

SOLDERING FOOTPRINT*

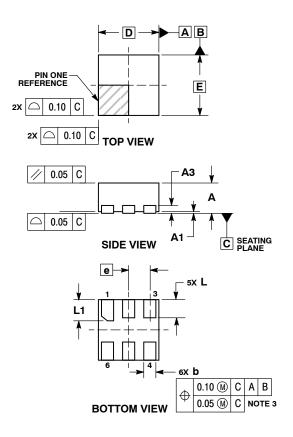


*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



PACKAGE DIMENSIONS

UDFN6 1.0x1.0, 0.35P CASE 517BX ISSUE O

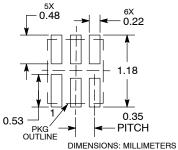


NOTES:

- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP. 4. PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

BURF	BURRS AND MOLD FL							
	MILLIMETERS							
DIM	MIN	MAX						
Α	0.45 0.55							
A1	0.00 0.05							
A3	0.13 REF							
b	0.12 0.22							
D	1.00	BSC						
E	1.00	BSC						
е	0.35	BSC						
Ĺ	0.25	0.35						
L1	0.30	0.40						

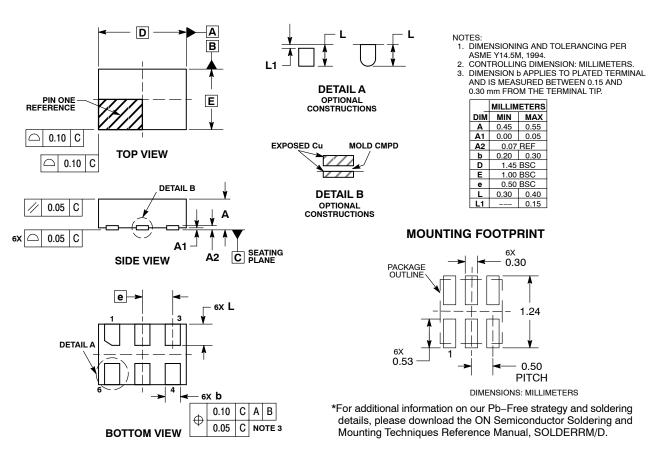
RECOMMENDED **SOLDERING FOOTPRINT***



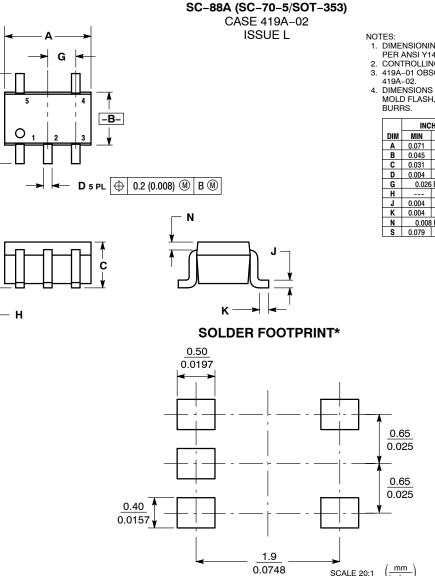
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

UDFN6 1.45x1.0, 0.5P CASE 517AQ ISSUE O



PACKAGE DIMENSIONS



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1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH. 419A-01 OBSOLETE. NEW STANDARD

DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.071	0.087	1.80	2.20
В	0.045	0.053	1.15	1.35
С	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026	BSC	0.65 BSC	
Η		0.004		0.10
L	0.004	0.010	0.10	0.25
Κ	0.004	0.012	0.10	0.30
Ν	0.008 REF		0.20	REF
s	0.079	0.087	2.00	2.20